Received 3/15/12 from Robert Lillianfeld at Janis (see e-mail correspondence on last page of this doc): Comments (3/16/12): -- I designed and ordered this unit from Janis in early 1965 (I think), to examine reflectivity shifts due to temperature, and particularly wrt differential thermal expansion coefficients between substrate/thin films. This was the beginning of "strained lattice tuning," which has become a tool in semiconductor device fabrication. -- I recall I only ran a few "tests" on this unit during my "two month postdoc" stint the summer of 1965. I believe the dewar was used extensively by Bill Paul's students who inherited my lab thereafter. PAUL GRANT HEAT SINK
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